## Notice of References Cited Application/Control No. 10/749,396 Examiner W. Patty Chen Applicant(s)/Patent Under Reexamination YAMAMOTO, TAKESHI Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0048403	03-2003	Satoh, Hiroki	349/156
*	В	US-2003/0104291	06-2003	YI et al.	430/7
	С	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
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	К	US-			
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## **FOREIGN PATENT DOCUMENTS**

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	N					
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